INTEGRATED CIRCUITS



Product specification IC15 Data Handbook 1996 Jan 05



Philips Semiconductors

74F153

FEATURES

- Non-inverting outputs
- Separate enable for each section
- Common select inputs
- See 74F253 for 3-State version

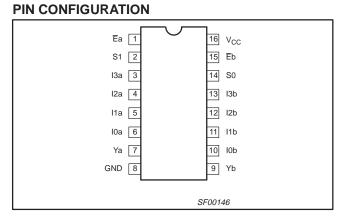
DESCRIPTION

The 74F153 is a dual 4-input multiplexer that can select 2 bits of data from up to four sources selected by common Select inputs (S0, S1). The two 4-input multiplexer circuits have individual active-Low Enables (Ea, Eb) which can be used to strobe the outputs independently. Outputs (Ya, Yb) are forced Low when the corresponding Enables (Ea, Eb) are High.

The 74F153 is the logic implementation of a 2-pole, 4-position switch where the switch is determined by the logic levels supplied to the common select inputs.

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F153	7.0ns	12mA

INPUT AND OUTPUT LOADING AND FAN-OUT TABLE



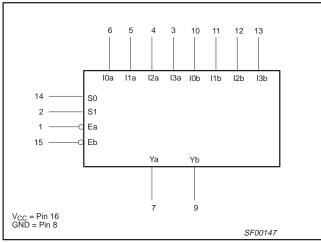
ORDERING INFORMATION

DESCRIPTION	$\begin{array}{l} \text{COMMERCIAL RANGE} \\ \text{V}_{\text{CC}} = 5\text{V} \pm 10\%, \\ \text{T}_{\text{amb}} = 0^{\circ}\text{C to} + 70^{\circ}\text{C} \end{array}$	PKG. DWG. #		
16-pin plastic DIP	N74F153N	SOT38-4		
16-pin plastic SO	N74F153D	SOT109-1		

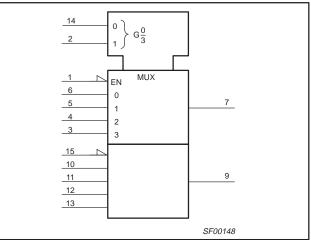
PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
10a – 13a	Port A data inputs	1.0/1.0	20µA/0.6mA
10b – 13b	Port B data inputs	1.0/1.0	20µA/0.6mA
S0, S1	Common Select inputs	1.0/1.0	20µA/0.6mA
Ēa	Port A Enable input (active Low)	1.0/1.0	20µA/0.6mA
Ēb	Port B Enable input (active Low)	1.0/1.0	20µA/0.6mA
Ya, Yb	Port A, B data outputs	50/33	1.0μΑ/20mA

NOTE: One (1.0) FAST unit load is defined as: 20µA in the High state and 0.6mA in the Low state.

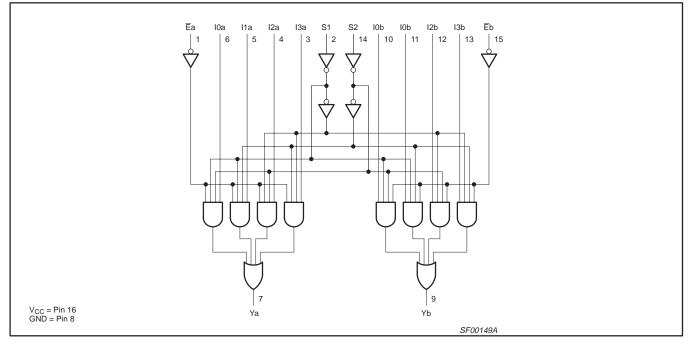
LOGIC SYMBOL



IEC/IEEE SYMBOL



LOGIC DIAGRAM



FUNCTION TABLE

			INPUTS				OUTPUT
S0	S1	Ēn	l0n	l1n	l2n	l3n	Yn
Х	Х	н	Х	Х	Х	Х	L
L	L	L	L	х	х	х	L
L	L	L	н	х	х	х	Н
н	L	L	х	L	х	х	L
н	L	L	х	н	х	х	Н
L	н	L	х	х	L	х	L
L	н	L	Х	х	н	х	Н
Н	н	L	Х	х	х	L	L
Н	н	L	Х	Х	Х	Н	Н

H = High voltage level L = Low voltage level X = Don't care

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ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device. Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	–0.5 to V_{CC}	V
I _{OUT}	Current applied to output in Low output state	40	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	DADAMETED		UNIT			
STMBOL	PARAMETER	MIN	NOM	MAX	UNIT	
V _{CC}	Supply voltage	4.5	5.0	5.5	V	
V _{IH}	High-level input voltage	2.0			V	
V _{IL}	Low-level input voltage			0.8	V	
I _{IK}	Input clamp current			-18	mA	
I _{OH}	High-level output current			-1	mA	
I _{OL}	Low-level output current			20	mA	
T _{amb}	Operating free-air temperature range	0		+70	°C	

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER		TEST COND				UNIT		
STMBOL			TESTCOND	TEST CONDITIONS ¹			MAX		
M	High-level output voltage		$V_{CC} = MIN, V_{IL} = MAX$	$\pm 10\% V_{CC}$	2.5			v	
V _{OH}	High-level output voltage		$V_{IH} = MIN, I_{OH} = MAX$	±5%V _{CC}	2.7	3.4		v	
Max	Low-level output voltage		$V_{CC} = MIN, V_{IL} = MAX$	±10%V _{CC}		0.30	0.50	v	
V _{OL}			$V_{IH} = MIN, I_{OL} = MAX$	±5%V _{CC}		0.30	0.50	v	
V _{IK}	Input clamp voltage		$V_{CC} = MIN, I_I = I_{IK}$		-0.73	-1.2	V		
l _l	Input current at maximum inpu	it voltage	$V_{CC} = MAX, V_I = 7.0V$			100	μA		
I _{IH}	High-level input current		$V_{CC} = MAX, V_I = 2.7V$			20	μΑ		
IIL	Low-level input current		$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA	
I _{OS}	Short-circuit output current ³		V _{CC} = MAX		-60		-150	mA	
Icc	Supply current (total)		V _{CC} = MAX	Ēn = GND, Sn=In=4.5V		12	20	mA	
		I _{CCL}		En=Sn=In=GND		12	20	mA	

NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.

^{2.} All typical values are at $V_{CC} = 5V$, $T_{amb} = 25^{\circ}C$. 3. Not more than one output should be shorted at a time. For testing I_{OS} , the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

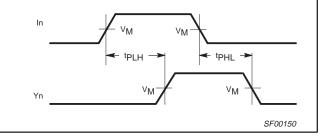
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AC ELECTRICAL CHARACTERISTICS

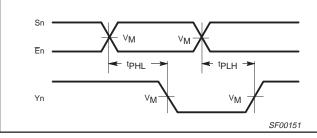
SYMBOL	PARAMETER	TEST CONDITION	V_{CC} = +5.0V T _{amb} = +25°C C _L = 50pF, R _L = 500Ω			V _{CC} = +5. T _{amb} = 0°C C _L = 50pF,	UNIT	
			MIN	ТҮР	MAX	MIN	MAX	
t _{PLH} t _{PHL}	Propagation delay In to Yn	Waveform 1	3.0 3.0	4.5 5.0	7.0 7.5	2.5 2.5	8.0 8.0	ns
t _{PLH} t _{PHL}	Propagation delay Sn to Yn	Waveform 2	5.0 5.0	8.0 8.0	10.5 10.5	4.5 4.5	12.0 12.0	ns
t _{PLH} t _{PHL}	Propagation delay En to Yn	Waveform 2	5.0 4.0	7.5 5.5	9.0 7.0	4.5 3.5	10.5 8.0	ns

AC WAVEFORMS

For all waveforms, $V_M = 1.5V$.

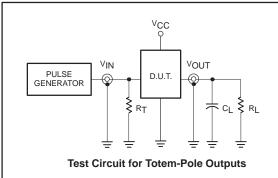


Waveform 1. Propagation Delay, Data to Output



Waveform 2. Propagation Delay, Enable and Select to Output

TEST CIRCUIT AND WAVEFORMS



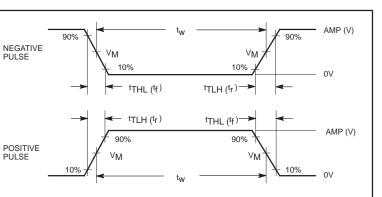
DEFINITIONS:

R_L = Load resistor;

 see AC ELECTRICAL CHARACTERISTICS for value.

 CL
 Load capacitance includes jig and probe capacitance; see AC ELECTRICAL CHARACTERISTICS for value.

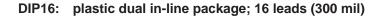
 $\begin{array}{l} \text{see AC ELECTRICAL CHARACTERISTICS for value} \\ \text{R}_{\text{T}} = & \text{Termination resistance should be equal to } \text{Z}_{\text{OUT}} \text{ of} \\ \text{pulse generators.} \end{array}$

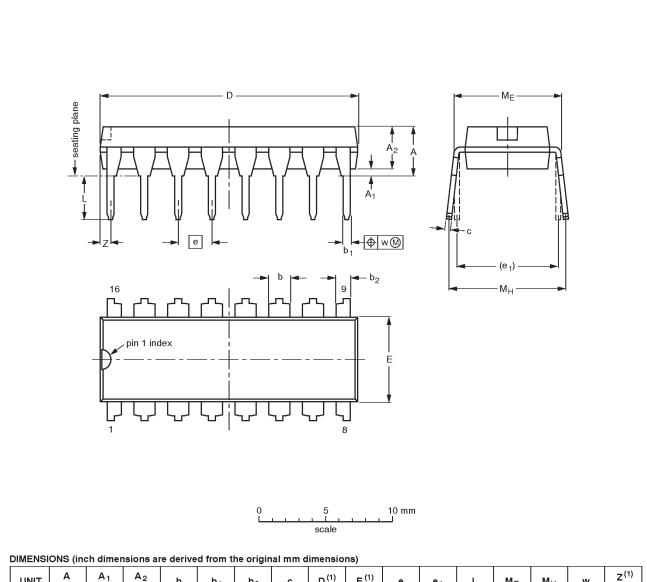


Input Pulse Definition

fomily	INPUT PULSE REQUIREMENTS						
family	amplitude	olitude V _M rep. rate		tw	t _{TLH}	t _{THL}	
74F	3.0V	1.5V	1MHz	500ns	2.5ns	2.5ns	

SF00006





UNIT	A max.	A ₁ min.	A ₂ max.	b	b ₁	b ₂	с	D ⁽¹⁾	E ⁽¹⁾	e	e ₁	L	ME	M _H	w	Z ⁽¹⁾ max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	1.25 0.85	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	0.76
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.049 0.033	0.014 0.009	0.77 0.73	0.26 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.030

Note

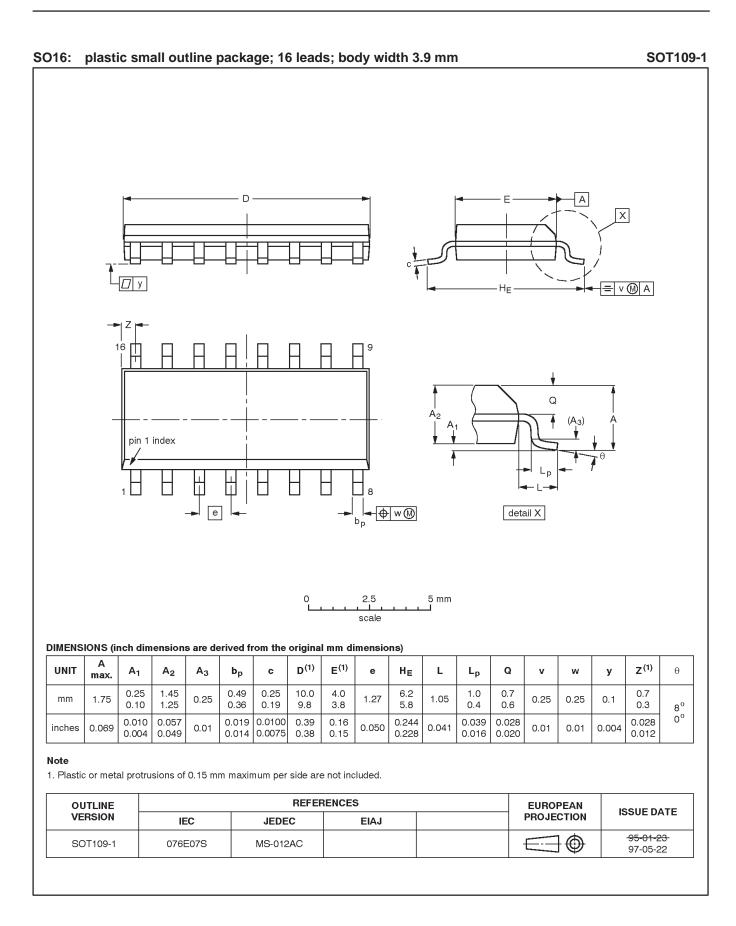
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT38-4						-92-11-17 95-01-14

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SOT38-4

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Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

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